Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,808	CHAE ET AL.	
Examiner	Art Unit	
Wai-Sing Louie	2814	

	SEARCHED				
Class	Subclass	Date	Examiner		
			<del></del>		
			45.		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
257/81,9	94,99,103	7/19/2006	WSL		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
light-emitting device, GaN-based, ohmic contact, La-alloy, Ni-alloy, ITO	8/11/2005	WSL
LED, p-electrode, zinc-nickel alloy, hydrogen absorption	7/19/2006	WSL
257/81,94,99,103	7/19/2006	WSL